

Notice of References Cited

Application/Control No.

09/252,925

Applicant(s)/Patent Under

Reexamination

OHNISHI ET AL.

Examiner

Hanh Nguyen

Art Unit

2662

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6151634	11-2000	Glaser et al.	709/236
	B	US-6665082 B1	12-2003	Takeoka et al.	358/1.15
	C	US-6141702	10-2000	Ludtke et al.	709/253
	D	US-6438613 B1	08-2002	Yeung et al.	709/250
	E	US-6310699 B1	10-2001	Kawasaki	358/434
	F	US-5812772	09-1998	Hasegawa	709/202
	G	US-6462832 B1	10-2002	Malik	358/1.15
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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